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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/586,174	07/17/2006	Toshihiko Ohashi	MAT-8868US	2827
52473 RATNERPRES	7590 06/08/200 STIA	EXAMINER		
P.O. BOX 980	CE DA 10492	OMAR, AHMED H		
VALLEY FORGE, PA 19482			ART UNIT	PAPER NUMBER
		2858		
			MAIL DATE	DELIVERY MODE
			06/08/2009	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Advisory Action Before the Filing of an Appeal Brief

Application No.	Applicant(s)	
10/586,174	OHASHI ET AL.	
Examiner	Art Unit	

	ALIMED OWAK	2030	
The MAILING DATE of this communication appea	ars on the cover sheet with the o	correspondence add	ress
THE REPLY FILED <u>21 May 2009</u> FAILS TO PLACE THIS APPL	ICATION IN CONDITION FOR AL	LOWANCE.	
1. The reply was filed after a final rejection, but prior to or on application, applicant must timely file one of the following reapplication in condition for allowance; (2) a Notice of Apperor Continued Examination (RCE) in compliance with 37 Claperiods:	eplies: (1) an amendment, affidavi al (with appeal fee) in compliance	t, or other evidence, v with 37 CFR 41.31; o	vhich places the r (3) a Request
a) The period for reply expiresmonths from the mailing	date of the final rejection.		
b) The period for reply expires on: (1) the mailing date of this Ac no event, however, will the statutory period for reply expire la	lvisory Action, or (2) the date set forth ter than SIX MONTHS from the mailing	g date of the final rejection	on.
Examiner Note: If box 1 is checked, check either box (a) or (b) MONTHS OF THE FINAL REJECTION. See MPEP 706.07(f)) <u>.</u>		
Extensions of time may be obtained under 37 CFR 1.136(a). The date of have been filed is the date for purposes of determining the period of extender 37 CFR 1.17(a) is calculated from: (1) the expiration date of the state forth in (b) above, if checked. Any reply received by the Office later that may reduce any earned patent term adjustment. See 37 CFR 1.704(b). NOTICE OF APPEAL	ension and the corresponding amount of an arrow or tended statutory period for reply origing the statutory period for reply origing the statutory period for reply original statutory.	of the fee. The appropri- nally set in the final Offic	ate extension fee be action; or (2) as
2. ☐ The Notice of Appeal was filed on A brief in compli	iance with 37 CFR 41 37 must be	filed within two month	s of the date of
filing the Notice of Appeal was filed on A brief in complete filing the Notice of Appeal (37 CFR 41.37(a)), or any exten Notice of Appeal has been filed, any reply must be filed with	sion thereof (37 CFR 41.37(e)), to	avoid dismissal of the	
<u>AMENDMENTS</u>			
 The proposed amendment(s) filed after a final rejection, b They raise new issues that would require further con 			cause
(b) ☐ They raise the issue of new matter (see NOTE below	v);		
(c) ☑ They are not deemed to place the application in betto appeal; and/or	er form for appeal by materially red	ducing or simplifying t	ne issues for
(d) $igsqcup$ They present additional claims without canceling a $lpha$	orresponding number of finally reje	ected claims.	
NOTE: (See 37 CFR 1.116 and 41.33(a)).			
4. 🔲 The amendments are not in compliance with 37 CFR 1.12		mpliant Amendment (PTOL-324).
5. Applicant's reply has overcome the following rejection(s):			
6. Newly proposed or amended claim(s) would be allow non-allowable claim(s).			-
7. For purposes of appeal, the proposed amendment(s): a) how the new or amended claims would be rejected is provious The status of the claim(s) is (or will be) as follows: Claim(s) allowed: Claim(s) objected to:		l be entered and an e	xplanation of
Claim(s) rejected: <u>1 and 3-6</u> .			
Claim(s) withdrawn from consideration: <u>2</u> . AFFIDAVIT OR OTHER EVIDENCE			
 The affidavit or other evidence filed after a final action, but because applicant failed to provide a showing of good and was not earlier presented. See 37 CFR 1.116(e). 			
 The affidavit or other evidence filed after the date of filing a entered because the affidavit or other evidence failed to over showing a good and sufficient reasons why it is necessary 	rercome <u>all</u> rejections under appea and was not earlier presented. Se	al and/or appellant fail see 37 CFR 41.33(d)(1	s to provide a).
10. ☐ The affidavit or other evidence is entered. An explanation REQUEST FOR RECONSIDERATION/OTHER	of the status of the claims after er	ntry is below or attach	ed.
11. The request for reconsideration has been considered but See Continuation Sheet.	does NOT place the application in	condition for allowan	ce because:
12. ☐ Note the attached Information <i>Disclosure Statement</i>(s). (I13. ☐ Other:	PTO/SB/08) Paper No(s)		
/Patrick J Assouad/	/AUMED OMAD/		
Supervisory Patent Examiner, Art Unit 2862	/AHMED OMAR/ Examiner, Art Unit 2858		
, , ,	Examiner, Art Offit 2000		

Continuation Sheet (PTO-303)

Application No.

Claim 1 continues to be rejected under 35 U.S.C. 103(a) as being obvious over ROKUTO in view of SASAKI. The examiner has considered the applicant's argument but they were not found persuasive to overcome the prior rejection. The examiner understands the applicant's argument that circuit disclosed by SASAKI if duplicated would not be able to detect the under voltage abnormal condition for a plurality of series connected capacitors, However the examiner explains that the claim is rejected under 103(a) which incorporates both the references of ROKUTO and SASAKI. ROKUTO discloses a circuit which detects the voltage across a plurality of capacitors connected in series and compares these voltages to a high voltage in order to determine an over-voltage abnormal condition, SASAKI discloses a circuit for comparing the voltage across a single capacitor to a low voltage value to detect an under-voltage abnormal condition. The combination of ROKUTO and SASAKI is done by modifying the ROKUTO circuit to include the comparison to low voltage disclosed by SASAKI to determine the under voltage abnormal condition. The examiner has further explained that both ROKUTO and SASAKI are analogous art as they deal with capacitor testing and provided the motivation to combine both references as: "...for the benefit of providing increased protection of the capacitor unit".